



Notice of References Cited

Application No.

09/471,460

Examiner

Calvin Lee

Applicant(s)

Figura et al.

Group Art Unit

2825

Page 1 of 1

U.S. PATENT DOCUMENTS							
*		DOCUMENT NO.	DATE	NAME		CLASS	SUBCLASS
	A	6,089,183	07/18/00	Im	ai et al.	118	723
	В	5,048,413	01/28/92	Fuji	ita et al.	437	189
	С						
	D						
	E						
	F						
	G						
	н			And the state of t	W W		
	ı						<u></u>
	J				AND THE PARTY OF T		<u> </u>
	к						
	L						
	М						
FOREIGN PATENT DOCUMENTS							
*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
	N						·
	0	j					
	Р						
	Q				·		
	R						
	s						
	т						
NON-PATENT DOCUMENTS							
* DOCUMENT (Including Author, Title, Source, and Pertinent Pages)							DATE
x	U	Ephrath, L. M., "Teflon Polymer Mask for RIE of Contact Roles", IBM Technical Disclosure Bulletin, Vol. 25, No. 9, pp. 4587-4588					FALSE
	v						
e é	w						
	х						

A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)